

Supplementary Information

Understanding the Interplay between Crystal Structure and Charge Transport in Alloyed Lead-free Perovskites

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Table S1. Average P, R, D characteristics of the studied lateral devices (symbols in brackets show standard deviation). Bandgaps were estimated using Tauc plot, * denotes for indirect bandgap.

Material	Dimensionality	Bandgap (ass) eV	405 nm			532 nm			650 nm		
			P %	R mA/W	D Jones	P %	R mA/W	D Jones	P %	R mA/W	D Jones
MA ₃ BiI _{2.9}	0D	1.91*	51.4 (8.2)	2.8 (0.0925)	1.8·10 ⁸ (0.0925)	2.15 (48.8)	0.0041 (48.8)	2.4·10 ⁵ (48.8)	-	-	-
MA ₃ (Bi _{0.6} Sb _{0.4})I _{2.9}	0D	1.89*	25 (8.2)	1.3 (0.0925)	8.4·10 ⁷ (0.0925)	3.9 (48.8)	0.0067 (48.8)	4.1·10 ⁵ (48.8)	-	-	-
MA₃SbI_{2.9}	0D	1.91*	314 (8.2)	19 (0.0925)	1.2·10⁹ (0.0925)	8.0 (48.8)	0.13 (48.8)	2.6·10⁶ (48.8)	4.6 (63.2)	0.4 (0.38)	7.4·10 ⁶ (0.38)
MA ₃ Bi(I _{0.6} Br _{0.4}) _{2.9}	2D	2.25	3.6 (8.2)	0.16 (0.371)	1·10 ⁷ (0.371)	-	-	-	-	-	-
MA ₃ (Bi _{0.6} Sb _{0.4})(I _{0.6} Br _{0.4}) _{2.9}	2D	2.23	55.3 (8.2)	2.4 (0.371)	1.6·10 ⁸ (0.371)	6.8 (48.8)	0.012 (48.8)	7.3·10 ⁵ (48.8)	-	-	-
MA₃Sb(I_{0.6}Br_{0.4})_{2.9}	2D	2.28	315 (8.2)	19 (0.0925)	1.2·10⁹ (0.0925)	8.9 (48.8)	0.016 (48.8)	1.0·10⁶ (48.8)	-	-	-
MA ₃ BiBr _{2.9}	2D	2.74	-	-	-	-	-	-	-	-	-
MA ₃ (Bi _{0.6} Sb _{0.4})Br _{2.9}	2D	2.71	6.2 (8.2)	0.17 (0.371)	1.1·10 ⁷ (0.371)	-	-	-	-	-	-
MA ₃ SbBr _{2.9}	2D	2.75	58.9 (8.2)	4.2 (0.0925)	2.7·10 ⁸ (0.0925)	-	-	-	-	-	-

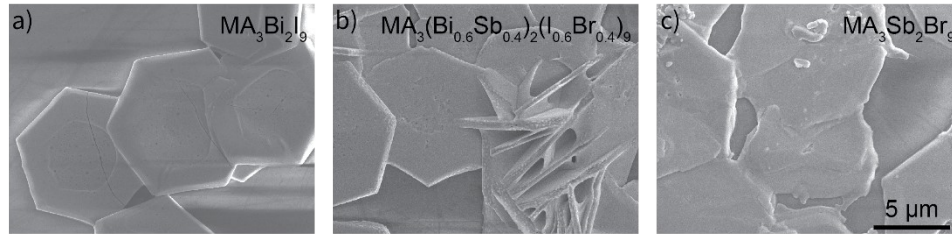


Figure S1. SEM images of 3 characteristic samples prepared on quartz showing micrometer size hexagonal grains and the resulting material exhibited the same carrier mobility but improved carrier lifetime.

Table S2. – THz measurements for 2 set of samples, prepared on quartz. (set #1 – bare perovskite solutions, #2– solutions with NH_4SCN additive).

Sample Set #1	THz mobility, $\text{cm}^2/\text{V/s}$	THz lifetime, ps
$\text{MA}_3\text{Bi}_2\text{Br}_9$, (2D)	0.4	8.7
$\text{MA}_3\text{Sb}_2\text{Br}_9$, (2D)	0.5	4.8
$\text{MA}_3(\text{Bi}_{0.6}\text{Sb}_{0.4})_2(\text{I}_{0.6}\text{Br}_{0.4})_9$, (2D)	0.6	6.6
$\text{MA}_3\text{Bi}_2\text{I}_9$ (0D)	0.3	2.8
$\text{MA}_3\text{Sb}_2\text{I}_9$, (0D)	0.4	1.2
Sample Set #2	THz mobility, $\text{cm}^2/\text{V/s}$	THz lifetime, ps
$\text{MA}_3(\text{Bi}_{0.6}\text{Sb}_{0.4})_2(\text{I}_{0.6}\text{Br}_{0.4})_9$, (2D)	0.4	12
$\text{MA}_3\text{Sb}_2\text{Br}_9$, (2D)	0.4	10
$\text{MA}_3\text{Bi}_2\text{I}_9$ (0D)	0.3	9

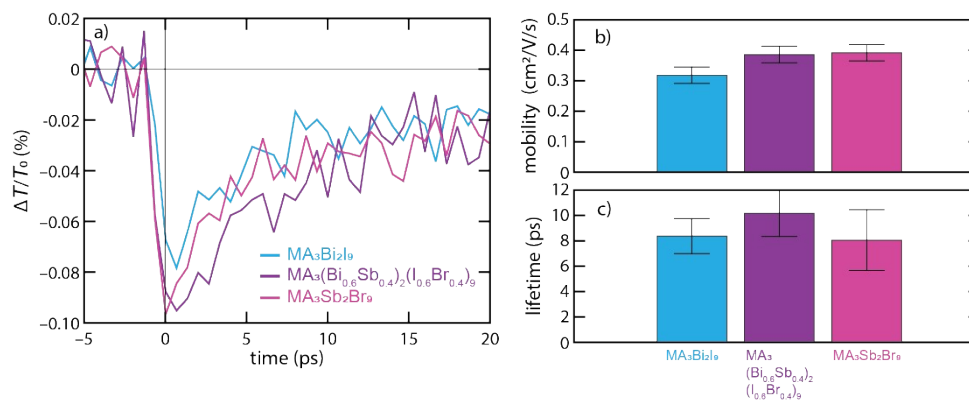


Figure S2. THz mobility and lifetime of samples prepared on quartz with the increased grain size, carrier lifetime increased to >9 ps for all samples while carrier mobilities remain the same.

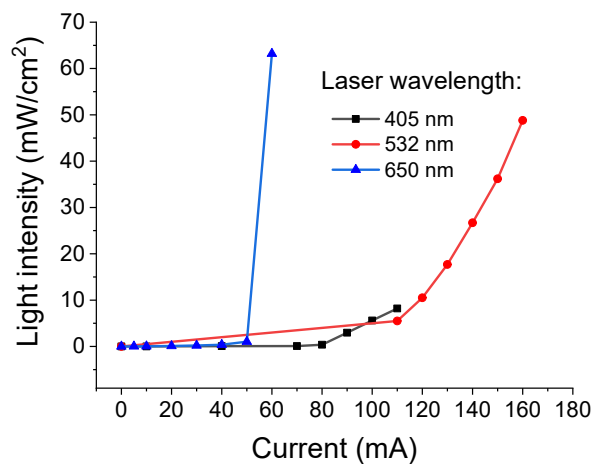


Figure S3. – Relation between laser light intensity and current

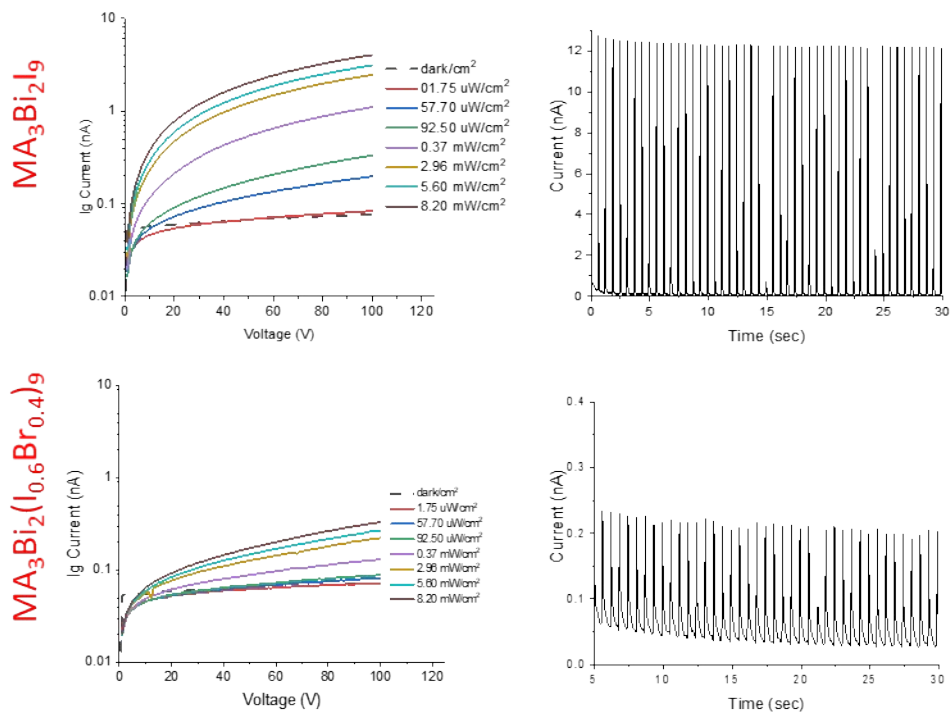


Figure S4. IV characteristics and transient photoresponse of Bi- systems ($\text{MA}_3\text{Bi}_2\text{Br}_9$ did not respond)

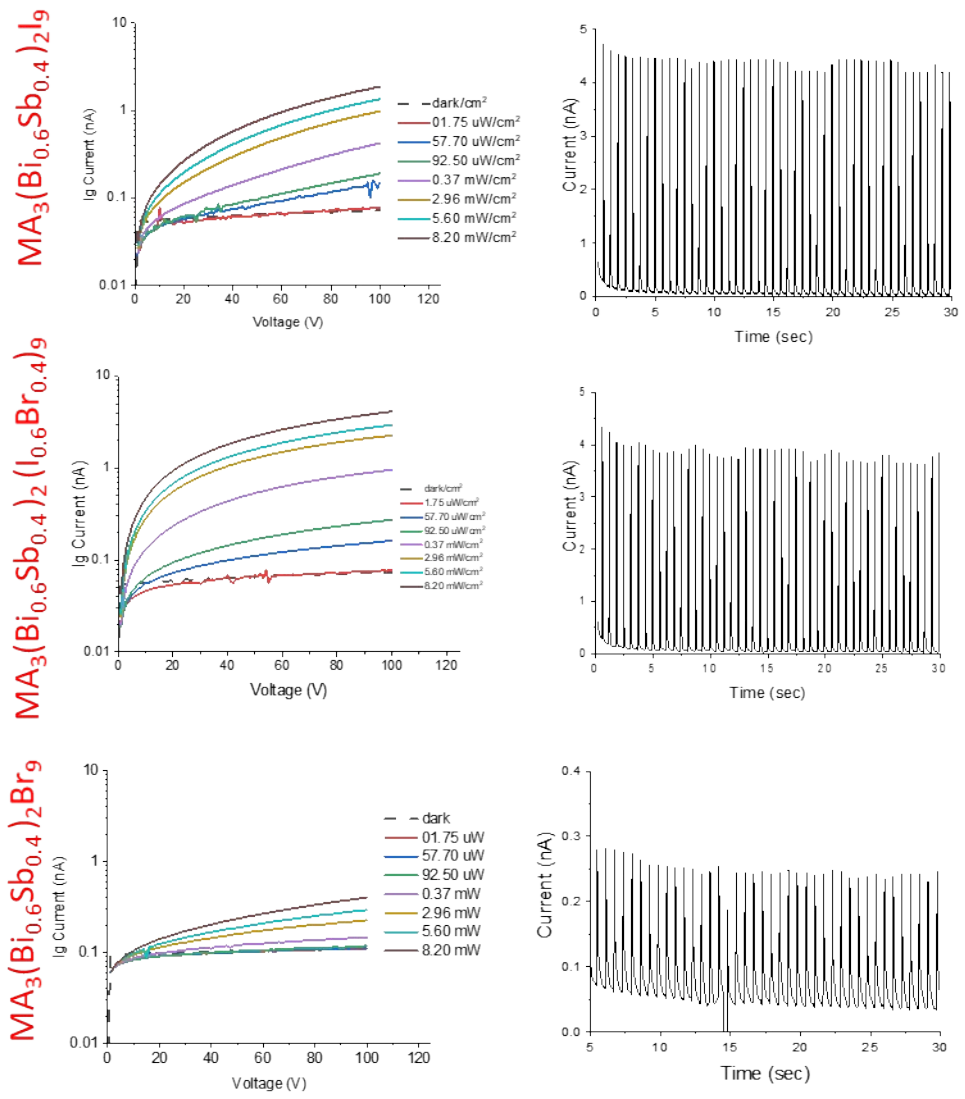


Figure S5. IV characteristics and transient photoresponse of Bi-Sb systems

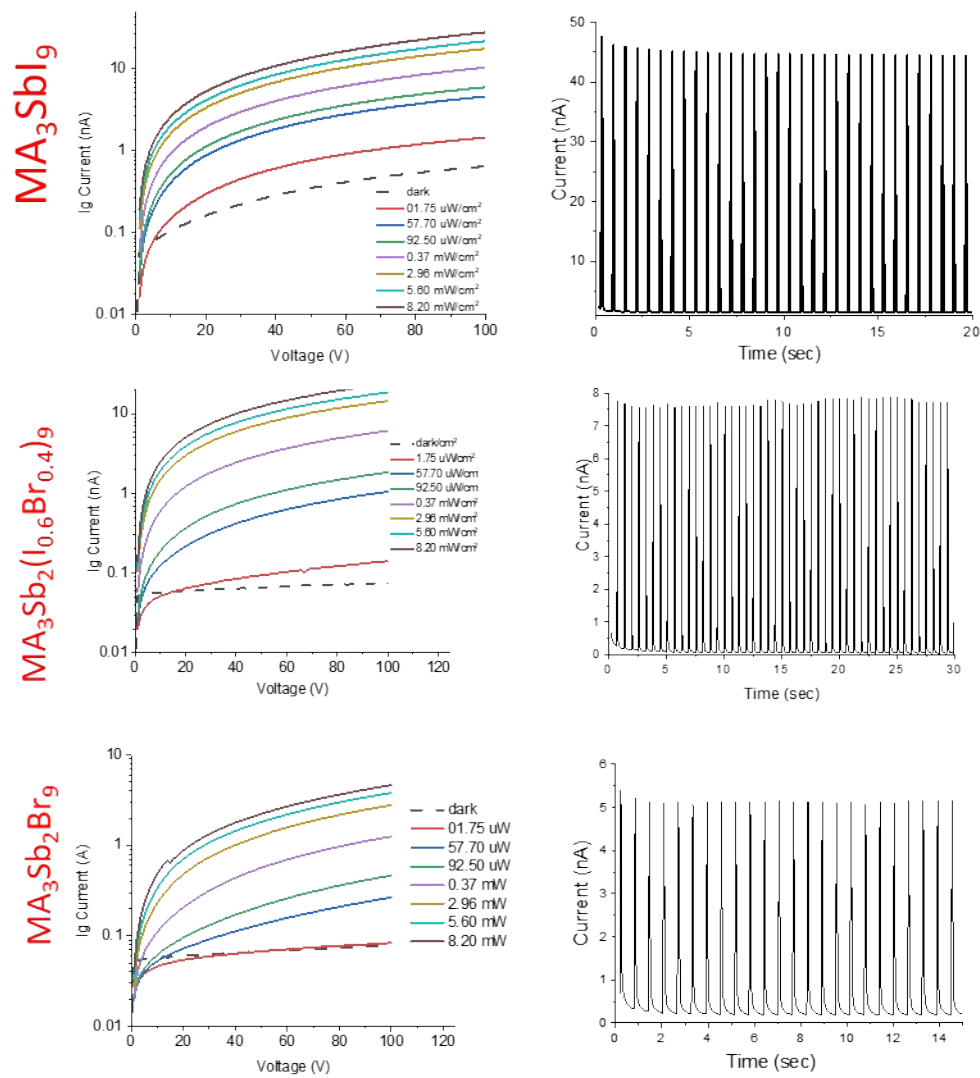


Figure S6. IV characteristics and transient photoresponse of Sb-systems

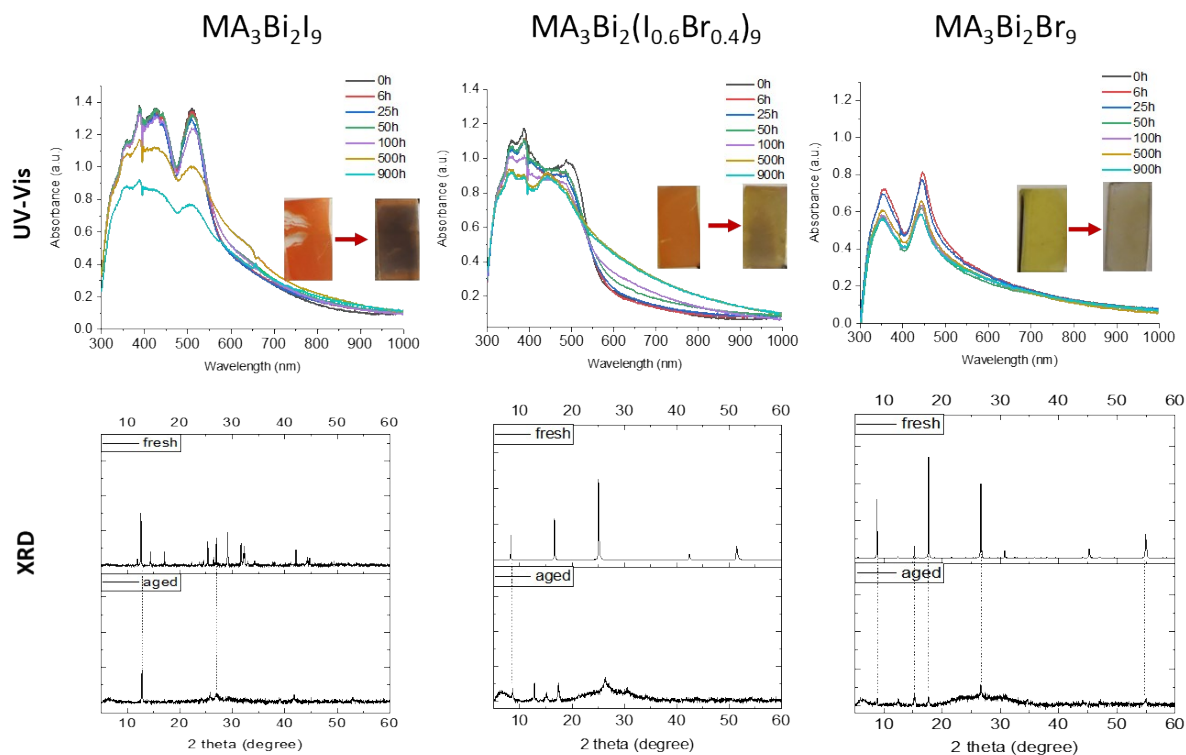


Figure S7. Change of UV-vis spectra(a) and XRD patern(b) of Bi-rich- systems.

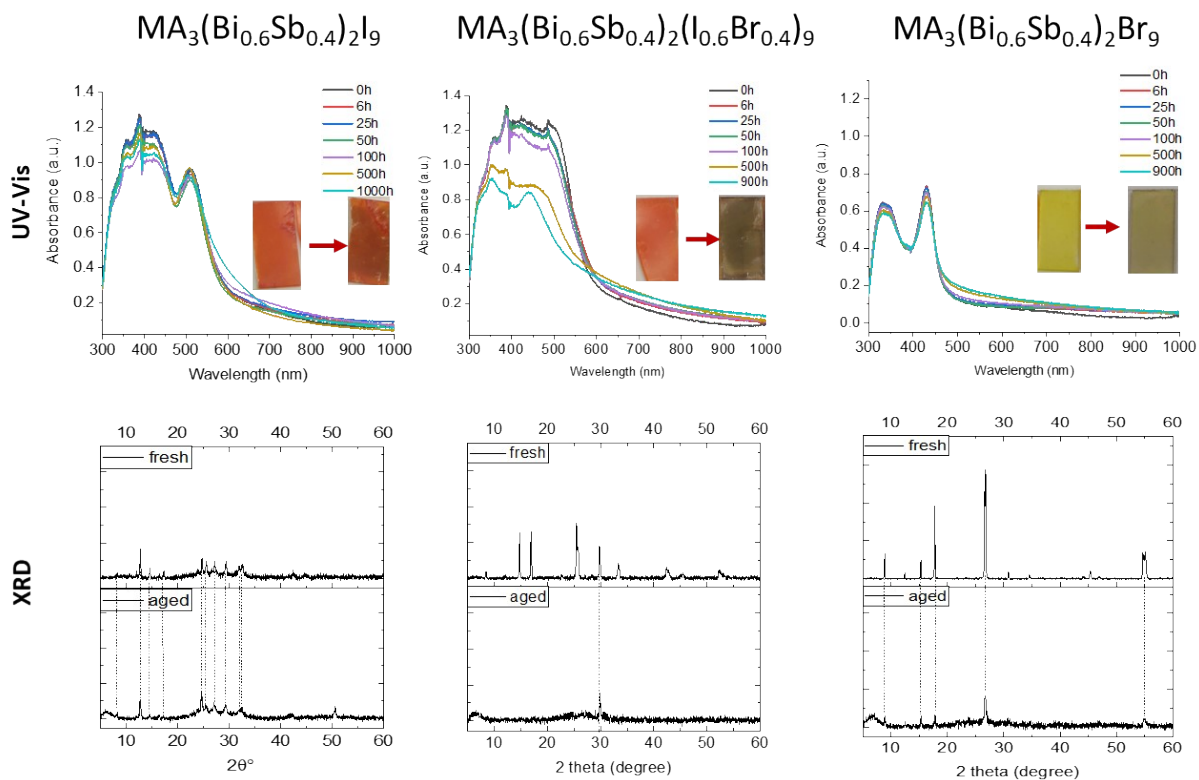


Figure S8. Change of UV-vis spectra(a) and XRD patern(b) Bi-Sb systems.

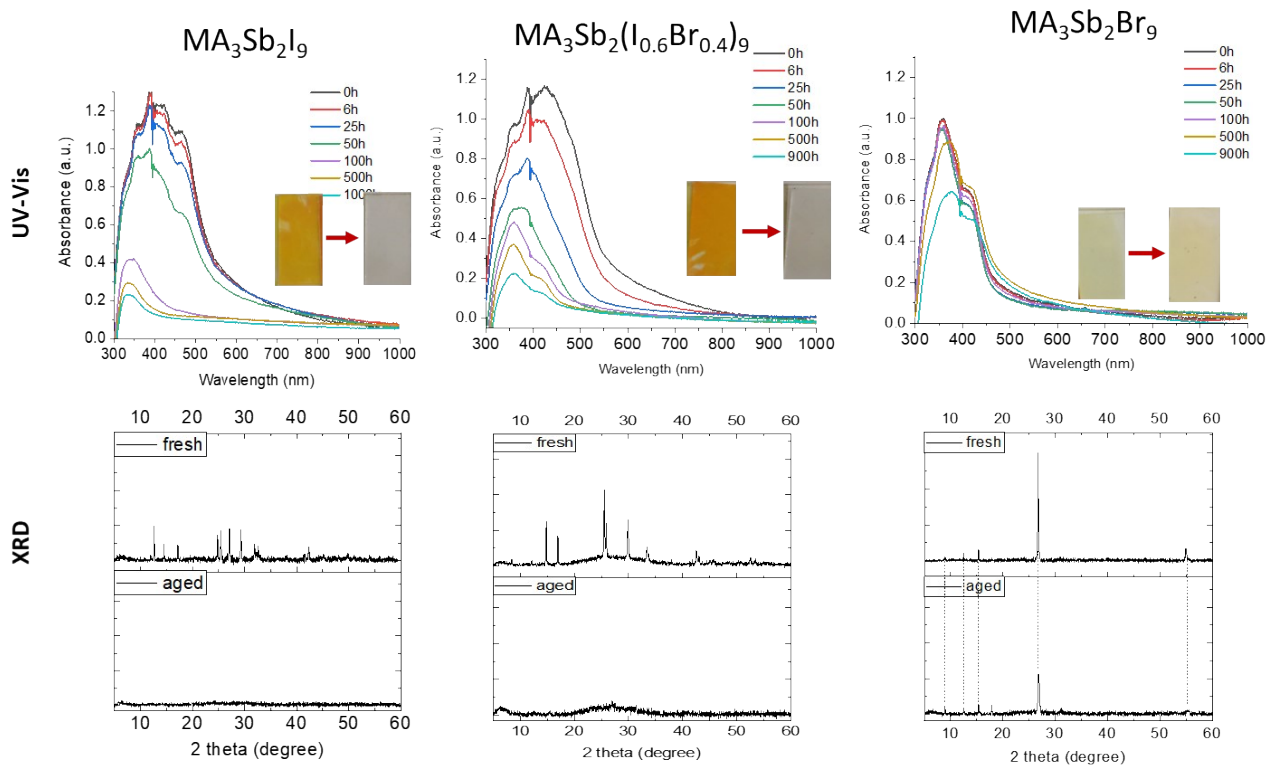


Figure S9. Change of UV-vis spectra(a) and XRD pattern(b) of Sb-rich systems.